5	e:	earch Notes						

Application/Control No.	Applicant(s)/Patent und Reexamination	er
09/905,755	CHENG ET AL.	
Examiner	Art Unit	
Jeffrey T. Barton	1753	

	SEARCHED				
Class	Subclass	Date	Examiner		
204	547, 643	9/30/2004	JTB		
435	173.7	9/30/2004	JTB		
435	173.9	9/30/2004	JTB		
435	285.2	9/30/2004	JTB		
435	287.2	9/30/2004	JTB		
435	306.1	9/30/2004	JTB		
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(11102001110 02	ARCH STRATEGY) 	
	DATE	EXMR	
See attached EAST	10/1/2004	JTB	